

<b>Notice of References Cited</b>		Application/Control No. 10/565,122	Applicant(s)/Patent Under Reexamination NICAISE, JEAN-LOUIS	
		Examiner TAN Q. NGUYEN	Art Unit 3661	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,836,024	06-1989	Woehrl et al.	307/10.1
*	B	US-5,995,892	11-1999	Kiribayashi et al.	701/45
*	C	US-6,023,664	02-2000	Bennet, Jeffrey S.	702/141
*	D	US-6,032,092	02-2000	Laaser, Walter	701/45
*	E	US-6,513,832	02-2003	Mader et al.	280/735
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.